**DE-16** Camera System

ultra high speed direct detection for in situ TEM

### Direct Electron delivers | bigger | better | faster | cameras for electron microscopy

### Better Science, Faster – Brilliant Results in Less Time

- PEL
- Direct detection device (DDD<sup>®</sup>) delivers high resolution, excellent sensitivity, and ultra-low noise.
- *4k* × *4k* (16.8 million) pixels.
- Ideal for materials science with the best dynamic range of any direct detector.
- High-speed continuous streaming for in situ TEM and "movie-mode" processing (motion correction).
- Unrivaled features, such as an integrated survey sensor, Faraday plate, and open-source software.
- Electron counting to maximize signal-to-noise ratio, when needed.
- The best of all the new TEM camera technology in a single integrated system.
- Low total cost-of-ownership and exceptional support.

In situ TEM experiment with an electrochemical liquid cell, showing dissolution of an electrode. Data was collected at 75 frames per second (fps). Courtesy of Haimei Zheng, Lawrence Berkeley National Lab. Published in Zeng, et al., *Faraday Discuss* 176 (2014).







Microscopy

Direct Electron

# Direct Electron

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| detection electron energy            | optimized for 80 keV – 1.25 MeV   |
|--------------------------------------|---|
| pixel array specification            | 4096 $	imes$ 4096 (16.8 million pixels) $\mid$ 6.5 $\mu$ m pixel pitch  |
| single electron SNR                  | ~50:1 (300 kV)  |
| sensor design                        | >3T pixel design with correlated double sampling (CDS)   backthinned   radiation hardened   |
| acquisition frame rate               | 60 fps max, unbinned full-frame $\mid$ 120 fps, bin 2× full-frame subarray readout up to 1920 fps max   |
| acquisition modes                    | integrating mode   counting mode (with optional counting system)  |
| exposure rate                        | large dynamic range with consistent performance in integrating mode (e.g., 4 – 800 e-/pixel/s)  |
| mounting position                    | fully retractable   mounted on-axis TEM bottom port or in JEOL film drawer  |
| "buddy" camera                       | integrated near-axis 2048 $	imes$ 2048 scintillator-coupled survey sensor   |
| exposure measurement                 | integrated Faraday plate for exposure measurement with each acquisition   |
| sensor protection                    | integrated physical protection shutter   microscope blanking/shuttering   failsafe software   |
| computer system                      | certified high-performance computer system with large >25 TB RAID array for data streaming  |
| image format                         | image data stored in non-proprietary format to ensure broad compatibility   |
| acquisition & processing<br>software | conventional acquisition: DE-IM (full-featured, user-friendly)   µManager (free, open-source)<br>in situ movie acquisition: DE-StreamPix (continuous streaming)<br>automated acquisition: Leginon   SerialEM   EMTools (TVIPS)   others using the DE SDK<br>"movie" processing: DE image processing software (free, open-source, Python-based)   others<br>customization: software development kit (SDK) for integration with custom software |

#### **Integrating Mode**

best for maximizing overall productivity



### **Electron Counting Mode**

best for maximizing signal-to-noise ratio



\* Note: Specifications and performance are subject to change

web

email



there is much more... phone

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